Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,929	LOOI ET AL.
Examiner	Art Unit
Raymond Phan	2111

SEARCHED			
Class	Subclass	Date	Examiner
710	300-306, 313-317	1/2/2007	RP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST	9/	/26/2006	RP